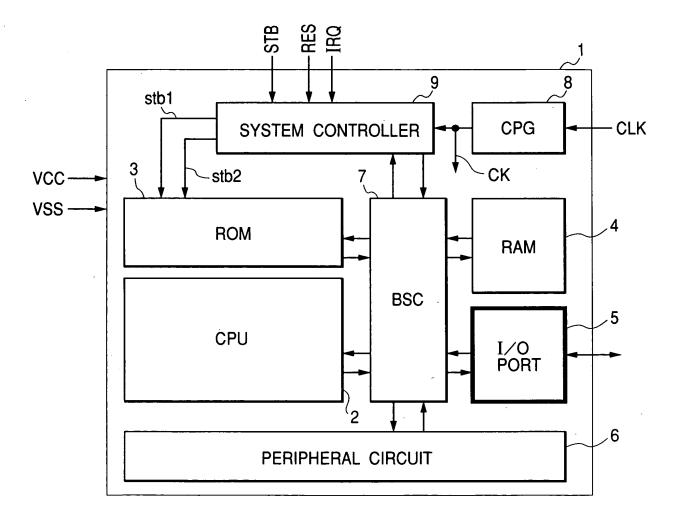
FIG. 1



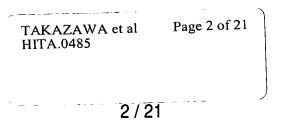


FIG. 2

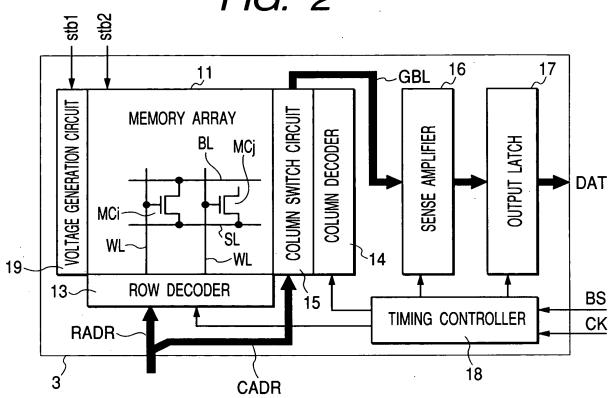
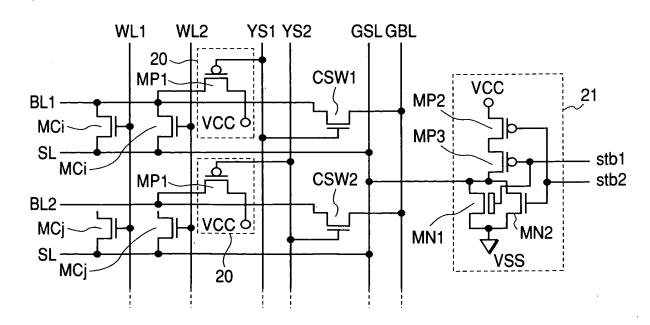
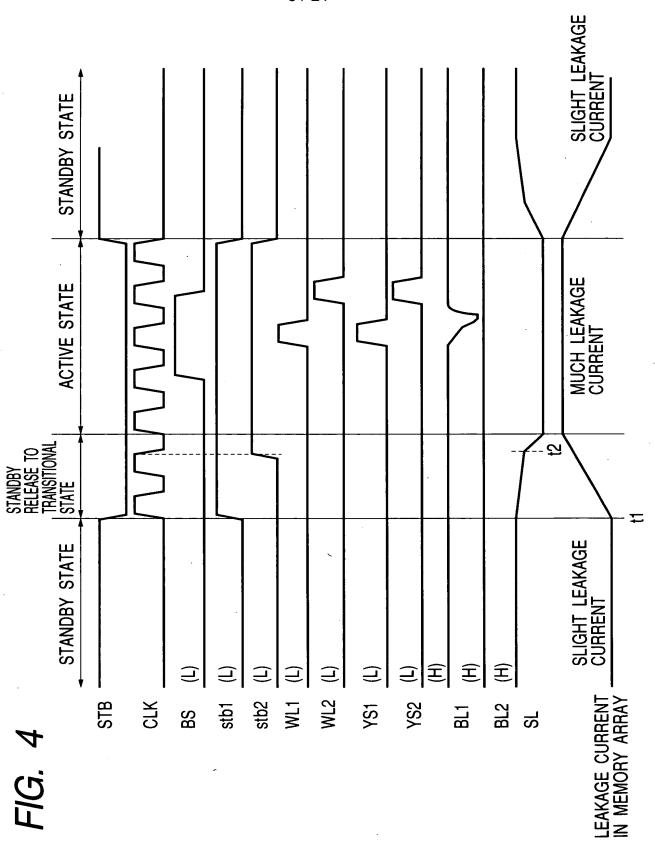


FIG. 3







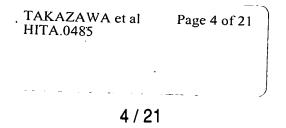


FIG. 5

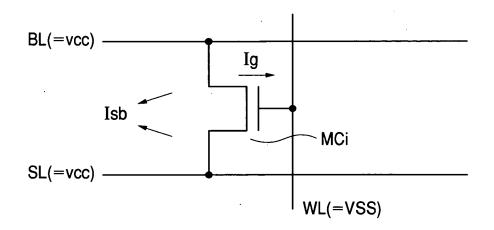


FIG. 6

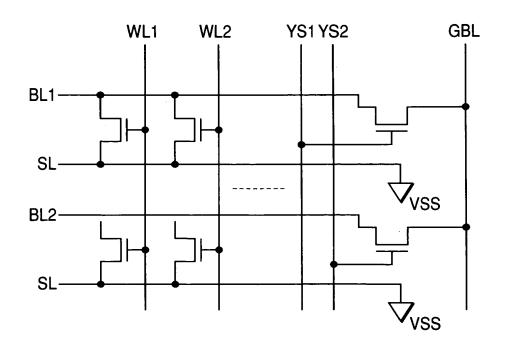
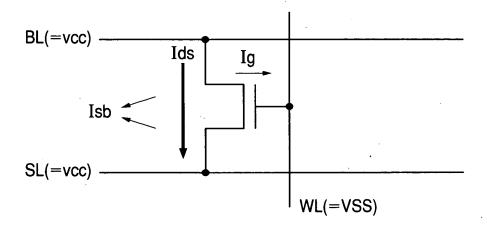


FIG. 7



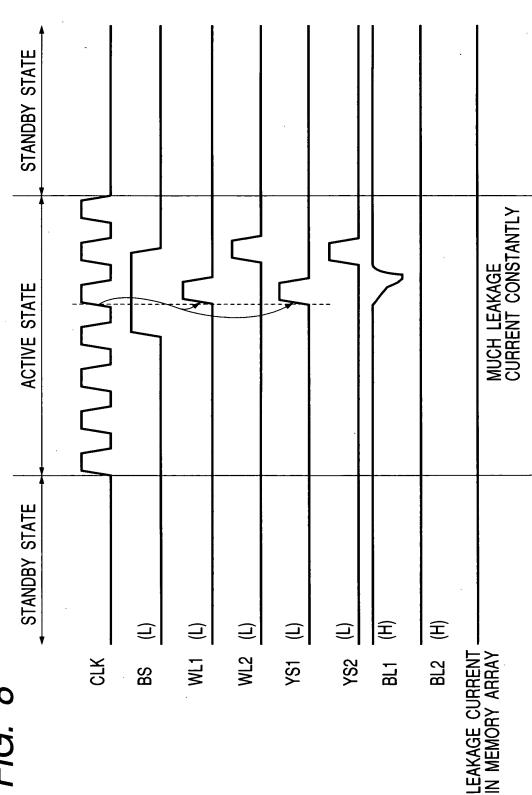


FIG. 8

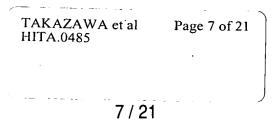
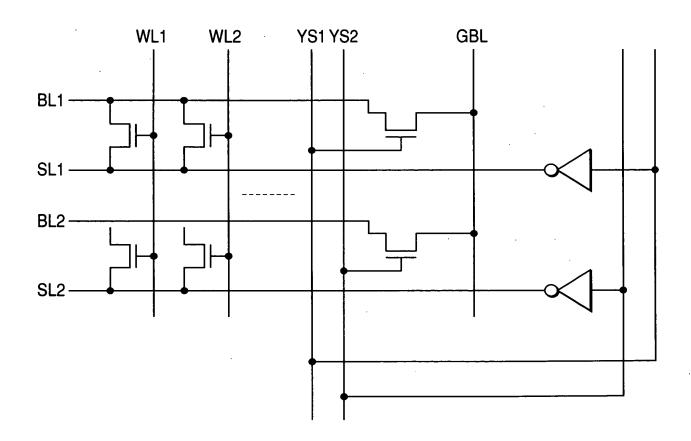
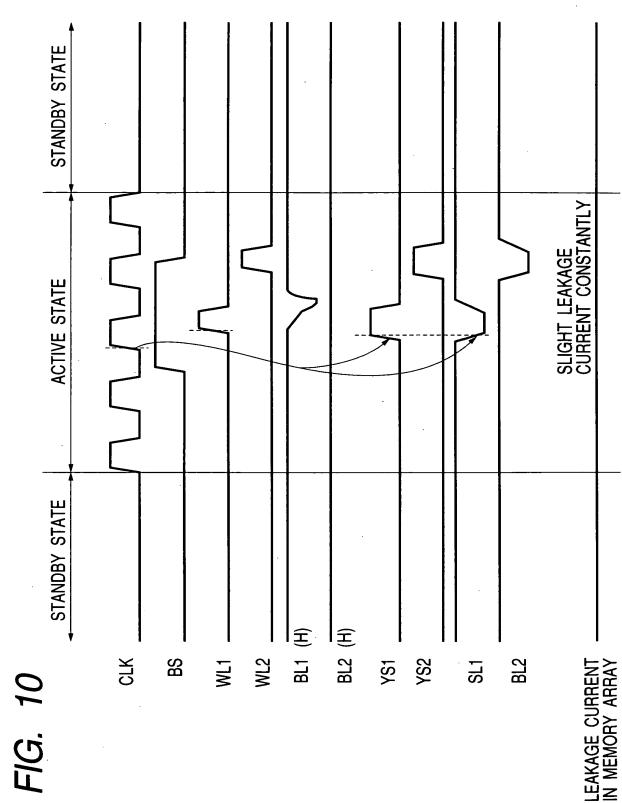


FIG. 9





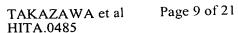
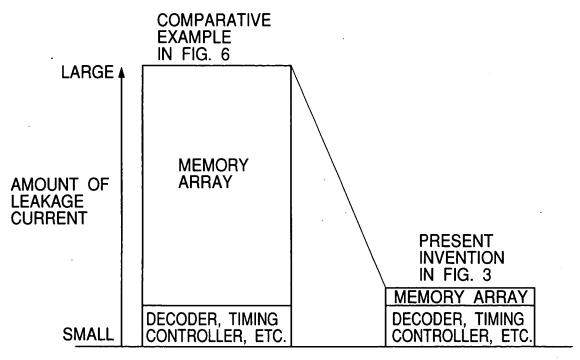
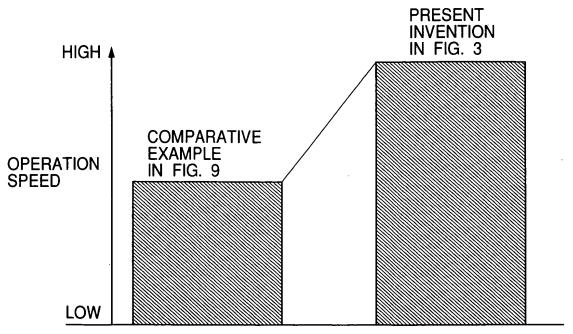


FIG. 11



EFFECT OF STANDBY LEAKAGE **CURRENT REDUCTION (RELATIVE)**

FIG. 12



OPERATION SPEED (RELATIVE)

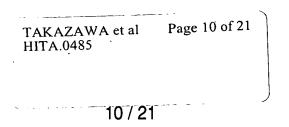


FIG. 13

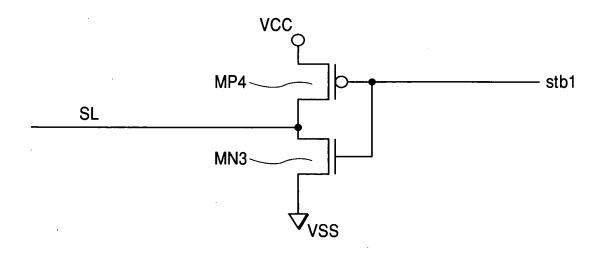
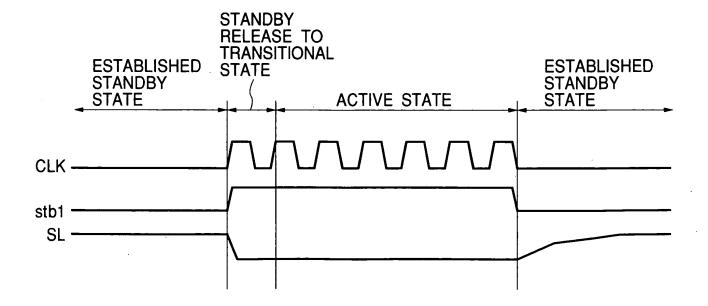
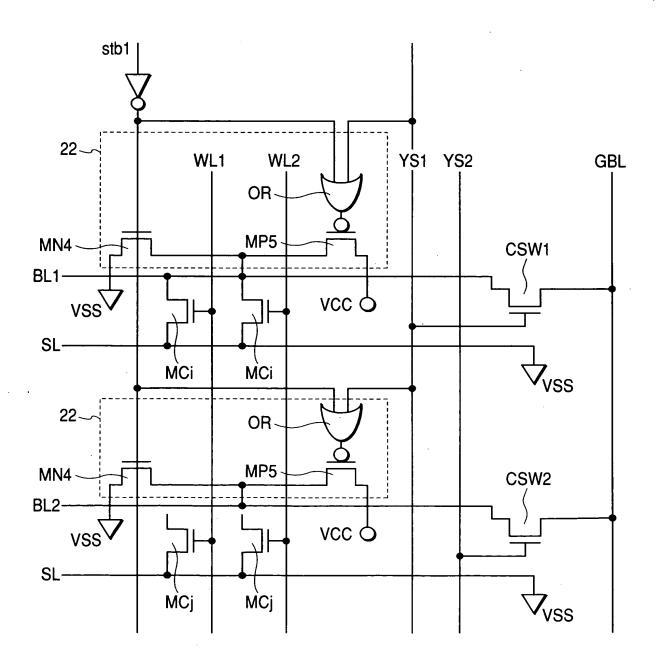


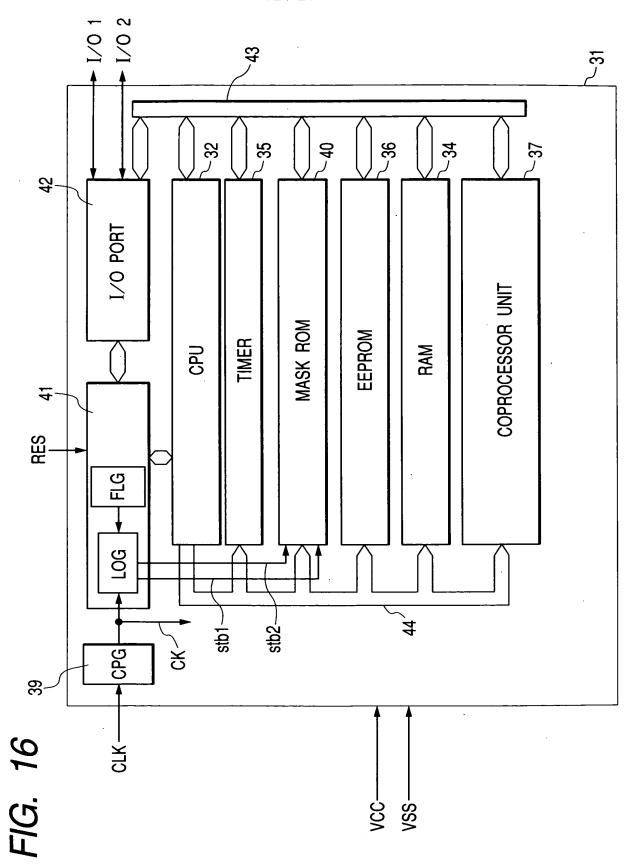
FIG. 14



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FIG. 15





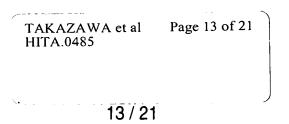


FIG. 17

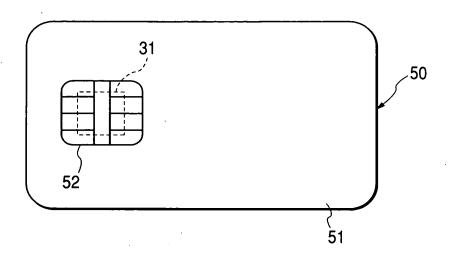


FIG. 18

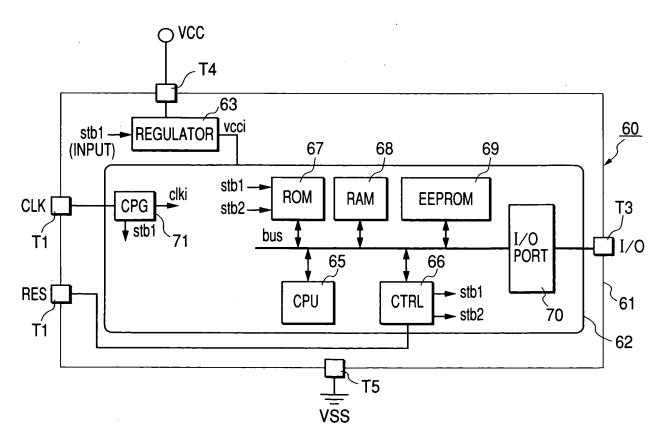
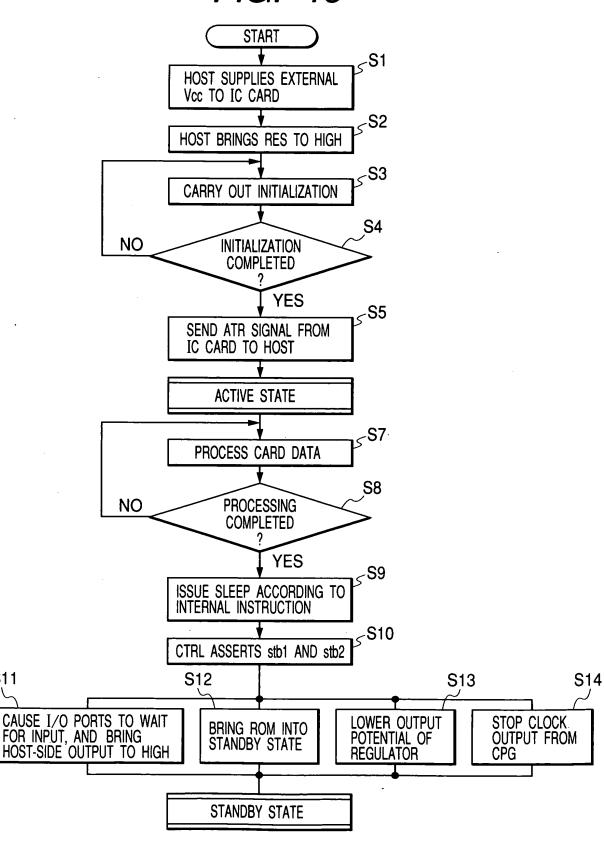
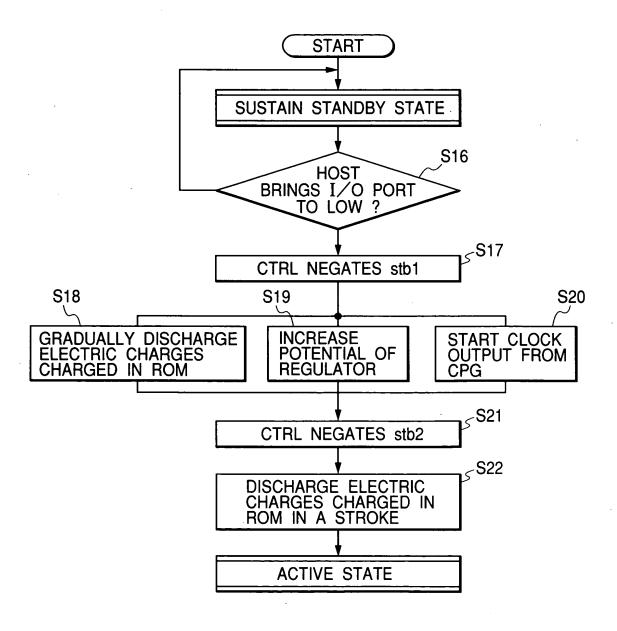


FIG. 19



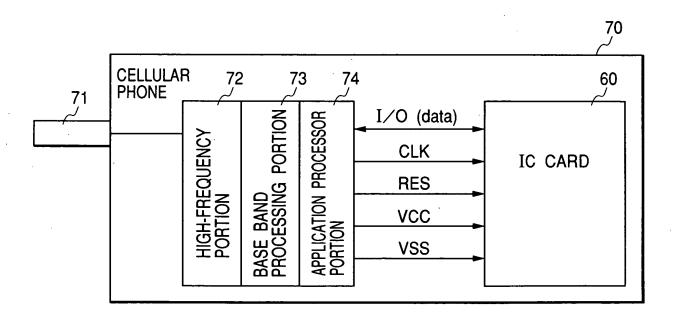
S11

FIG. 20



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FIG. 21



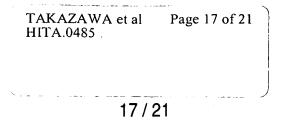
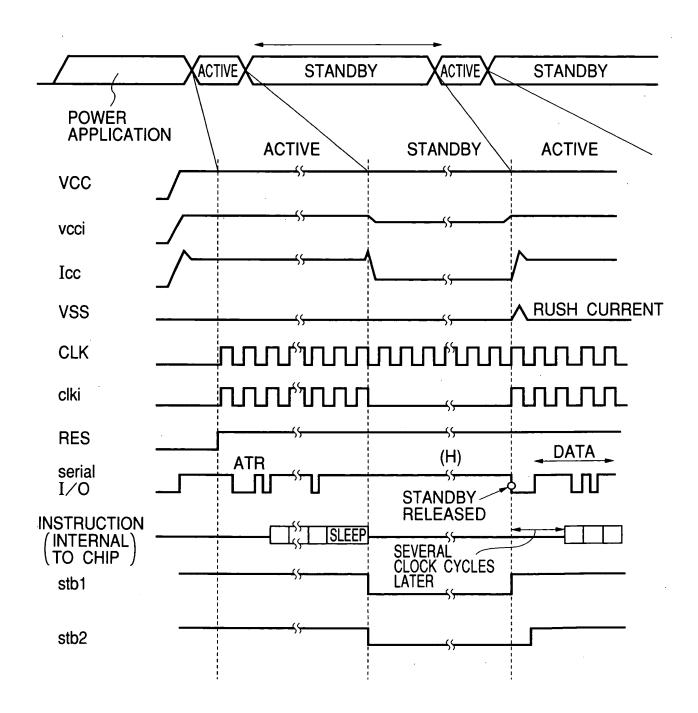


FIG. 22



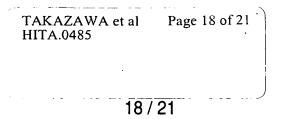


FIG. 23

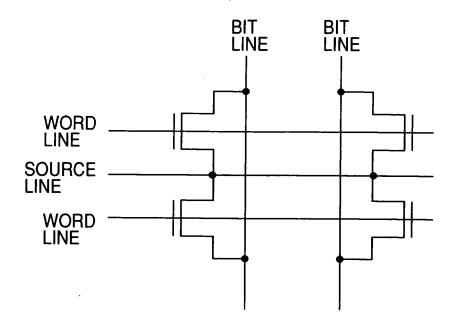
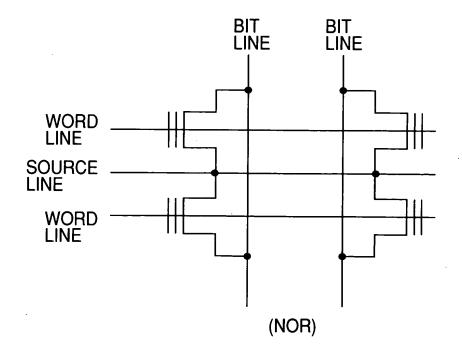
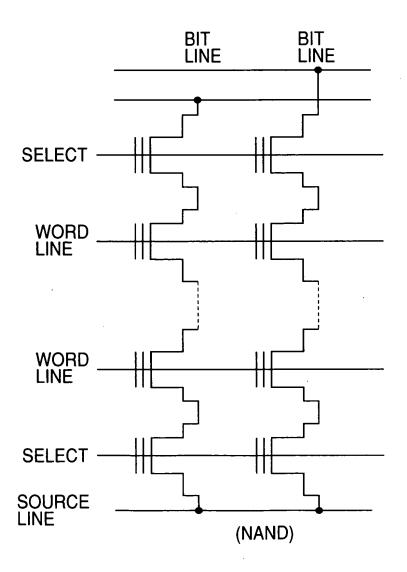


FIG. 24



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FIG. 25



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FIG. 26

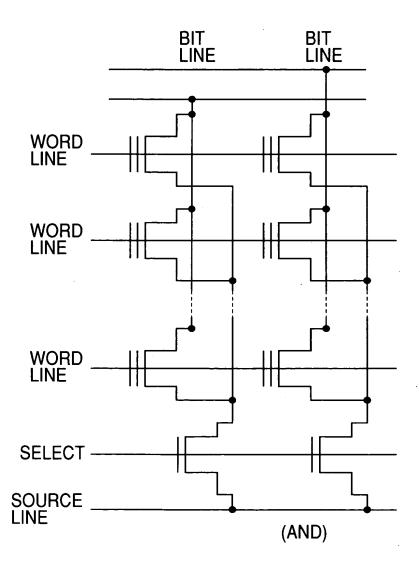


FIG. 27

